

LMU08/8U 8 x 8-bit Parallel Multiplier

FEATURES

- ☐ 35 ns Worst-Case Multiply Time
- Low Power CMOS Technology
- ☐ LMU08 Replaces TRW TMC208K
- ☐ LMU8U Replaces TRW TMC28KU
- ☐ Two's Complement (LMU08), or Unsigned Operands (LMU8U)
- ☐ Three-State Outputs
- ☐ DESC SMD No. 5962-88739
- ☐ Available 100% Screened to MIL-STD-883, Class B
- ☐ Package Styles Available:
 - 40-pin Plastic DIP
 - 40-pin Ceramic DIP
 - 44-pin Plastic LCC, J-Lead
 - 44-pin Ceramic LCC

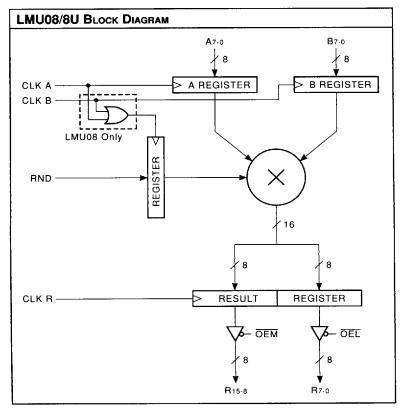
DESCRIPTION

The LMU08 and LMU8U are highspeed, low power 8-bit parallel multipliers. They are pin-for-pin equivalents with TRW TMC208K and TMC28KU type multipliers. Full military ambient temperature range operation is attained by the use of advanced CMOS technology.

Both the LMU08 and the LMU8U produce the 16-bit product of two 8-bit numbers. The LMU08 accepts operands in two's complement format, and produces a two's complement result. The product is provided in two halves with the sign bit replicated as the most significant bit of both halves.

This facilitates use of the LMU08 product as a double precision operand in 8-bit systems. The LMU8U operates on unsigned data, producing an unsigned magnitude result.

Both the LMU08 and the LMU8U feature independently controlled registers for both inputs and the product, which along with three-state outputs allows easy interfacing with microprocessor busses. Provision is made in the LMU08 and LMU8U for proper rounding of the product to 8-bit precision. The round input is loaded at the rising edge of the logical OR of CLK A and CLK B for the LMU08. The LMU8U latches RND on the rising edge of CLK A only. In either case, a '1' is added in the most significant position of the lower product byte when RND is asserted. Subsequent truncation of the least significant product byte results in a correctly rounded 8-bit result.



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FIGURE 1A. INPUT FORMATS

AIN

BIN

LMU08 Fractional Two's Complement

- LMU08 Integer Two's Complement

- LMU8U Unsigned Fractional -

- LMU8U Unsigned Integer -

FIGURE 1B. OUTPUT FORMATS

MSP

LSP

- LMU08 Fractional Two's Complement -----

LMU08 Integer Two's Complement

LMU8U Unsigned Fractional

- LMU8U Unsigned Integer -

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Storage temperature	65°C to +150°C
Operating ambient temperature	55°C to +125°C
Vcc supply voltage with respect to ground	0.5 V to +7.0 V
Input signal with respect to ground	3.0 V to +7.0 V
Signal applied to high impedance output	3.0 V to +7.0 V
Output current into low outputs	25 mA
Latchup current	> 400 mA

OPERATING CONDITIONS	To meet specified electrical	and switching characteristics

Mode	Temperature Range (Ambient)	Supply Voltage
Active Operation, Commercial	0°C to +70°C	$4.75 \text{ V} \le \text{V} \text{CC} \le 5.25 \text{ V}$
Active Operation, Military	-55°C to +125°C	4.50 V ≤ V CC ≤ 5.50 V

ELECTRIC	ECTRICAL CHARACTERISTICS Over Operating Conditions (Note 4)					
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V OH	Output High Voltage	Vcc = Min., Iон = -2.0 mA	3.5			٧
V OL	Output Low Voltage	VCC = Min., IOL = 8.0 mA			0.5	٧
V 1H	Input High Voltage		2.0		Vcc	٧
V 1L	Input Low Voltage	(Note 3)	0.0		0.8	٧
lix	Input Current	Ground ≤ VIN ≤ VCC (Note 12)			±20	μΑ
loz	Output Leakage Current	Ground ≤ V OUT ≤ V CC (Note 12)			±20	μA
Icc1	Vcc Current, Dynamic	(Notes 5, 6)		8	24	mA
ICC2	Vcc Current, Quiescent	(Note 7)			1.0	mA

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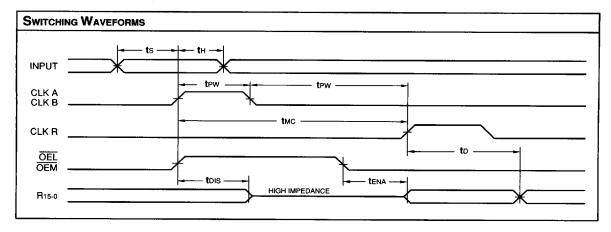


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SWITCHING CHARACTERISTICS

COMMERCIAL OPERATING RANGE (0°C to +70°C) Notes 9, 10 (ns)							
		LMU08/8U					
		70		50		35	
Symbol	Parameter	Min	Max	Min	Max	Min	Max
tMC	Clocked Multiply Time		70		50		35
tPW	Clock Pulse Width	20		20		10	
ts	Input Register Setup Time	14		14		14	
tн	Input Register Hold Time	4		0		0	
t D	Output Delay		25		20		20
tena	Three-State Output Enable Delay (Note 11)		24		22		22
tDIS	Three-State Output Disable Delay (Note 11)		22		20		20

MILITARY OPERATING RANGE (-55°C to +125°C) Notes 9, 10 (ns)							
		LMU08/8U-					
		90		60		45	
Symbol	Parameter	Min	Max	Min	Max	Min	Max
tMC	Clocked Multiply Time		90		60		45
tpw	Clock Pulse Width	25		20		15	
ts	Input Register Setup Time	20		15		15	
tH	Input Register Hold Time	5		0		0	
t D	Output Delay		35		22		22
tENA	Three-State Output Enable Delay (Note 11)		35		24		24
tDIS	Three-State Output Disable Delay (Note 11)		35		22		22



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NOTES

- 1. Maximum Ratings indicate stress specifications only. Functional operation of these products at values beyond those indicated in the Operating Conditions table is not implied. Exposure to maximum rating conditions for extended periods may affect reliability.
- 2. The products described by this specification include internal circuitry designed to protect the chip from damaging substrate injection currents and accumulations of static charge. Nevertheless, conventional precautions should be observed during storage, handling, and use of these circuits in order to avoid exposure to excessive electrical stress values.
- 3. This device provides hard clamping of transient undershoot and overshoot. Input levels below ground or above VCC will be clamped beginning at -0.6 V and VCC + 0.6 V. The device can withstand indefinite operation with inputs in the range of -0.5 V to +7.0 V. Device operation will not be adversely affected, however, input current levels will be well in excess of 100 mA.
- 4. Actual test conditions may vary from those designated but operation is guaranteed as specified.
- 5. Supply current for a given application can be accurately approximated

where

N = total number of device outputs

C = capacitive load per output

V = supply voltage

F = clock frequency

- 6. Tested with all outputs changing every cycle and no load, at a 5 MHz clock rate.
- 7. Tested with all inputs within 0.1 V of VCC or Ground, no load.
- 8. These parameters are guaranteed but not 100% tested.

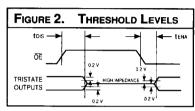
9. AC specifications are tested with input transition times less than 3 ns, output reference levels of 1.5 V (except tENA/tDIS test), and input levels of nominally 0 to 3.0 V. Output loading may be a resistive divider which provides for specified IOH and IOL at an output voltage of VOH min and VOL max respectively. Alternatively, a diode bridge with upper and lower current sources of IOH and IOL respectively, and a balancing voltage of 1.5 V may be used. Parasitic capacitance is 30 pF minimum, and may be distributed. For tENABLE and tDISABLE measurements, the load current is increased to 10 mA to reduce the RC delay component of the measurement.

This device has high-speed outputs capable of large instantaneous current pulses and fast turn-on/turn-off times. As a result, care must be exercised in the testing of this device. The following measures are recommended:

- a. A 0.1 µF ceramic capacitor should be installed between VCC and Ground leads as close to the Device Under Test (DUT) as possible. Similar capacitors should be installed between device VCC and the tester common, and device ground and tester common.
- b. Ground and VCC supply planes must be brought directly to the DUT socket or contactor fingers.
- c. Input voltages should be adjusted to compensate for inductive ground and VCC noise to maintain required DUT input levels relative to the DUT ground pin.
- 10. Each parameter is shown as a minimum or maximum value. Input requirements are specified from the point of view of the external system driving the chip. Setup time, for example, is specified as a minimum since the external system must supply at least that much time to meet the worst-case requirements of all parts. Responses from the internal circuitry are specified from

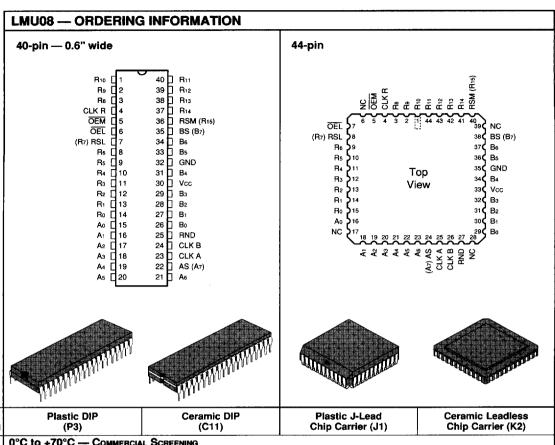
the point of view of the device. Output delay, for example, is specified as a maximum since worst-case operation of any device always provides data within that time.

- 11. Transition is measured ±200 mV from steady-state voltage with specified loading.
- 12. These parameters are only tested at the high temperature extreme, which is the worst case for leakage current.



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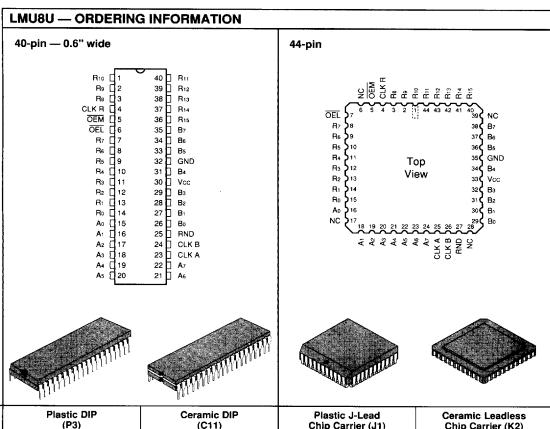


Speed	Plastic DIP (P3)	Ceramic DIP (C11)	Plastic J-Lead Chip Carrier (J1)	Ceramic Leadless Chip Carrier (K2)
	0°C to +70°C — COMMERCIA	AL SCREENING	· · · · · · · · · · · · · · · · · · ·	· · · · · · · · · · · · · · · · · · ·
70 ns	LMU08PC70	LMU08CC70	LMU08JC70	LMU08KC70
50 ns	LMU08PC50	LMU08CC50	LMU08JC50	LMU08KC50
35 ns	LMU08PC35	LMU08CC35	LMU08JC35	LMU08KC35
	-55°С to +125°С — Сомм	ERCIAL SCREENING		
90 ns		LMU08CM90		LMU08KM90
60 ns		LMU08CM60	1	LMU08KM60
45 ⊓s		LMU08CM45		LMU08KM45
	-55°C to +125°C MIL-S	TD-883 COMPLIANT		
90 ns		LMU08CMB90		LMU08KMB90
60 ns		LMU08CMB60	1	LMU08KMB60
		LMU08CMB45	1	LMU08KMB45

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Speed	Plastic DIP (P3)	Ceramic DIP (C11)	Plastic J-Lead Chip Carrier (J1)	Ceramic Leadless Chip Carrier (K2)
	0°C to +70°C - COMMERC	AL SCREENING		
70 ns	LMU8UPC70	LMU8UCC70	LMU8UJC70	LMU8UKC70
50 ns	LMU8UPC50	LMU8UCC50	LMU8UJC50	LMU8UKC50
35 ns	LMU8UPC35	LMU8UCC35	LMU8UJC35	LMU8UKC35
	-55°C to +125°C — Comm	ERCIAL SCREENING	1	
90 ns		LMU8UCM90		LMU8UKM90
60 ns		LMU8UCM60		LMU8UKM60
45 ns		LMU8UCM45		LMU8UKM45
	-55°C to +125°C - MIL-	STD-883 COMPLIANT		
90 ns		LMU8UCMB90		LMU8UKMB90
60 ns		LMU8UCMB60		LMU8UKMB60
45 ns		LMU8UCMB45		LMU8UKMB45

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